

TH25D-20UA

Ultra Low Power, 2M-bit

Serial Multi I/O Flash Memory Datasheet

Jun. 10, 2021

Performance Highlight

- ♦ Wide Supply Range from 1.65 to 3.6V for Read, Erase and Program
- Ultra Low Power consumption for Read, Erase and Program
- ♦ X1 and X2 Multi I/O Support
- ♦ High reliability with 100K cycling and 20 Year-retention



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1. Overview

1.1.General

- Single 1.65V to 3.60V supply
 - 1.65V-3.6V for Read, Erase and Program Operations
- Industrial Temperature Range -40C to 85C
- Serial Peripheral Interface (SPI) Compatible:
 - Mode 0 and Mode 3
- Single and Dual IO mode
 - 2M x 1 bit
 - 1M x 2 bits
- Flexible Architecture for Code and Data Storage
 - Uniform 256-byte Page Program
 - Uniform 256-byte Page Erase
 - Uniform 4K-byte Sector Erase
 - Uniform 32K/64K-byte Block Erase
 - Full Chip Erase

1.2. Performance

Fast read

- 2 I/O 100MHz with 4 dummy cycles, equivalent to 200M
- 1 I/O 100MHz with 8 dummy cycles
- Fast Program and Erase Speed
 - 1.3ms Page program time
 - 10ms Page erase time
 - 10ms 4K-byte sector erase time
 - 10ms 32K-byte block erase time
 - 10ms 64K-byte block erase time
- Ultra Low Power Consumption
 - 0.1uA Deep Power Down current
 - 10uA Standby current
 - 0.6mA Active Read current at 33MHz
 - 2.3mA Active Program or Erase current
- High Reliability
 - 100,000 Program / Erase Cycles
 - 20-year Data Retention

1.3. Software features

- One Time Programmable (OTP) Security Register
 - 3*512-Byte Security Registers With OTP Lock

- Software Protection Mode
 - The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits define the section of the memory array that can be read but not change.
- 128 bit unique ID for each device
- Program/Erase Suspend and Program/Erase Resume
- JEDEC Standard Manufacturer and Device ID Read Methodology

1.4. Hardware features

- Hardware Protection Mode
 - Hardware Controlled Locking of Protected Sectors by WP Pin
- Industry Standard Green Package Options
 - 8-pin SOP (150mil/208mil)
 - 8-land USON (2x3mm)
 - 8-land WSON (6x5mm)
 - 8-pin TSSOP
 - WLCSP
 - KGD for SiP



2. Description

The TH25D-20UA is a serial interface Flash memory device designed for use in a wide variety of high-volume consumer based applications in which program code is shadowed from Flash memory into embedded or external RAM for execution. The flexible erase architecture of the device, with its page erase granularity it is ideal for data storage as well, eliminating the need for additional data storage devices.

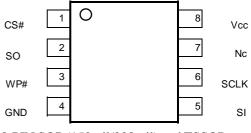
The erase block sizes of the device have been optimized to meet the needs of today's code and data storage applications. By optimizing the size of the erase blocks, the memory space can be used much more efficiently. Because certain code modules and data storage segments must reside by themselves in their own erase regions, the wasted and unused memory space that occurs with large sectored and large block erase Flash memory devices can be greatly reduced. This increased memory space efficiency allows additional code routines and data storage segments to be added while still maintaining the same overall device density.

The device also contains an additional 3*512-byte security registers with OTP lock (One-Time Programmable), can be used for purposes such as unique device serialization, system-level Electronic Serial Number (ESN) storage, locked key storage, etc.

Specifically designed for use in many different systems, the device supports read, program, and erase operations with a wide supply voltage range of 1.65V to 3.6V. No separate voltage is required for programming and erasing.

2.1. Pin Definition

Pin Configurations



8-PIN SOP (150mil/208mil) and TSSOP

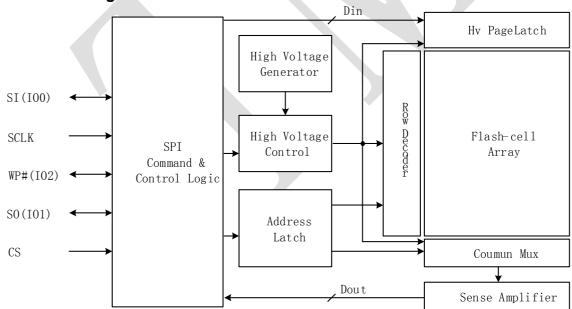
CS# 1 8 Vcc SO 2 7 Nc WP# 3 6 SCLK GND 4 5 SI

8-Land USON (2x3mm/6x5mm)

Pin Descriptions

No.	Symbol	Extension	Remarks
1	CS#		Chip select
2	SO	SIO1	Serial data output for 1 x I/O Serial data input and output for 2 x I/O read mode
3	WP#	SIO2	Write protection active low
4	GND	-	Ground of the device
5	SI	SIO0	Serial data input for 1x I/O Serial data input and output for 2 x I/O read mode
6	SCLK	-	Serial interface clock input
7	Nc	-	Not Connection
8	VCC	-	Power supply of the device

2.2. Block Diagram



2.3. Memory Address Mapping

The memory array can be erased in three levels of granularity including a full chip erase. The size of the erase blocks is optimized for both code and data storage applications, allowing both code and data segments to reside in their own erase regions.

Block64K	Block32K	Sector	Addres	s Range
	7	63	03F000H	03FFFFH
3	- 6			
		48	030000H	030FFFH
	15	47	02F000H	02FFFFH
2	5 - 4			
		32	020000H	020FFFH
		31	01F000H	01FFFFH
1	3 - 2			
		16	010000H	010FFFH
		15	00F000H	00FFFFH
0	1 - 0			
	Ŭ	0	000000H	000FFFH

TH25D-20UA Memory Organization



3. Device Operation

3.1. Mode0 and Mode3

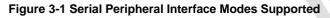
Before a command is issued, status register should be checked to ensure device is ready for the intended operation.

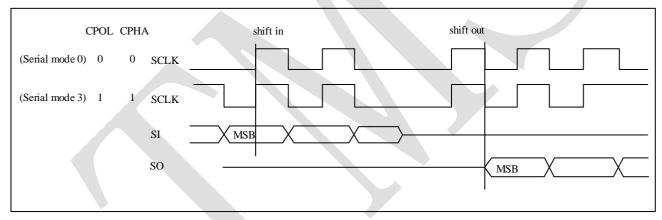
When incorrect command is inputted to this LSI, this LSI becomes standby mode and keeps the standby mode until next CS# falling edge. In standby mode, SO pin of this LSI should be High-Z. When correct command is inputted to this LSI, this LSI becomes active mode and keeps the active mode until next CS# rising edge.

Input data is latched on the rising edge of Serial Clock (SCLK) and data shifts out on the falling edge of SCLK. The difference of serial peripheral interface mode 0 and mode 3 is shown as Figure 3-1.

For the following instructions: RDID, RDSR, RDSR1, RDSCUR, READ, FAST_READ, DREAD, 2READ, RDSFDP, RES, REMS, DREMS, the shifted-in instruction sequence is followed by a data-out sequence. After any bit of data being shifted out, the CS# can be high. For the following instructions: WREN, WRDI, WRSR, PE, SE, BE32K, BE, CE, PP, DPP, DP, ERSCUR, PRSCUR, SUSPEND, RESUME, RSTEN, RST, the CS# must go high exactly at the byte boundary; otherwise, the instruction will be rejected and not executed.

During the progress of Write Status Register, Program, Erase operation, to access the memory array is neglected and not affect the current operation of Write Status Register, Program, Erase.





Note:

CPOL indicates clock polarity of serial master, CPOL=1 for SCLK high while idle, CPOL=0 for SCLK low while not transmitting. CPHA indicates clock phase. The combination of CPOL bit and CPHA bit decides which serial mode is supported.

3.2.IO MODE

Standard SPI

The TH25D-20UA features a serial peripheral interface on 4 signals bus: Serial Clock (SCLK), Chip Select (CS#), Serial Data Input (SI) and Serial Data Output (SO). Both SPI bus mode 0 and 3 are supported. Input data is latched on the rising edge of SCLK and data shifts out on the falling edge of SCLK.

Dual SPI

The TH25D-20UA supports Dual SPI operation when using the "Dual Output Fast Read" and "Dual I/O Fast Read" (3BHand BBH) commands. These commands allow data to be transferred to or from the device at two times the rate of the standard SPI. When using the Dual SPI command the SI and SO pins become bidirectional I/O pins: IO0 and IO1.

3.3. Status Register

S15	S14	S13	S12	S11	S10	S9	S8
SUS1	CMP	LB3	LB2	LB1	SUS2	Reserved	SRP1
S7	S6	S5	S4	S3	S2	S1	S0
SRP0	BP4	BP3	BP2	BP1	BP0	WEL	WIP

The definition of the status register bits is as below:

WIP bit.

The Write in Progress (WIP) bit indicates whether the memory is busy in program/erase/write status register progress. When WIP bit sets to 1, means the device is busy in program/erase/write status register progress, when WIP bit sets 0, means the device is not in program/erase/write status register progress.

WEL bit.

The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write Status Register, Program or Erase command is accepted.

BP4, BP3, BP2, BP1, BP0 bits.

The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits are non-volatile. They define the size of the area to be software protected against Program and Erase commands. These bits are written with the Write Status Register (WRSR) command. When the Block Protect (BP4, BP3, BP2, BP1, BP0) bits are set to 1, the relevant memory area (as defined in Table "Protected Area Sizes"). becomes protected against Page Program (PP), Page Erase (PE), Sector Erase (SE) and Block Erase (BE) commands. The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits can be written provided that the Hardware Protected mode has not been set. The Chip Erase (CE) command is executed, only if the Block Protect (BP4, BP3, BP2, BP1 and BP0) are set to "None protected".

SRP1, SRP0 bits.

The Status Register Protect (SRP1 and SRP0) bits are non-volatile Read/Write bits in the status register. The SRP bits control the method of write protection: software protection, hardware protection, power supply lock-down or one time programmable protection

SRP1	SRP0	WP#	Status Register	Description
0	0	х	Software Protected	The Status Register can be written to after a Write Enable command, WEL=1.(Default)
0	1	0	Hardware Protected	WP#=0, the Status Register locked and can not be written to.
0	1	1	Hardware Unprotected	WP#=1, the Status Register is unlocked and can be written to after a Write Enable command, WEL=1.
1	0	х		Status Register is protected and can not be written to again until the next Power-Down, Power-Up cycle.
1	1	х	One Time Program(2)	Status Register is permanently protected and can not be written to.

Note:

1. When SRP1, SRP0=(1, 0), a Power-Down, Power-Up cycle will change SRP1, SRP0 to (0, 0) state.

2. This feature is available on special order. Please contact TMC for details.



LB3, LB2, LB1, bits.

The LB3, LB2, LB1, bits are non-volatile One Time Program (OTP) bits in Status Register (S13-S11) that provide the write protect control and status to the Security Registers. The default state of LB3-LB1are0, the security registers are unlocked. The LB3-LB1bitscan be set to 1 individually using the Write Register instruction. The LB3-LB1bits are One Time Programmable, once its set to 1, the Security Registers will become read-only permanently.

CMP bit.

The CMP bit is a non-volatile Read/Write bit in the Status Register(S14). It is used in conjunction with the BP4-BP0 bits to provide more flexibility for the array protection. Please see the table "Protected Area Size" for details. The default setting is CMP=0.

SUS1, SUS2 bit.

The SUS1 and SUS2 bit are read only bit in the status register (S15 and S10) that are set to 1 after interrupting an program/erase/write status register progress by Program/Erase Suspend (75H or B0H) command (The Erase Suspend will set the SUS1 to 1, and the Program Suspend will set the SUS2 to 1). The SUS1 and SUS2 bit are cleared to 0 by Program/Erase Resume (7AH or 30H) command as well as a power-down, power-up cycle.

3.4. Data Protection

During power transition, there may be some false system level signals which result in inadvertent erasure or programming. The device is designed to protect itself from these accidental write cycles.

The state machine will be reset as standby mode automatically during power up. In addition, the control register architecture of the device constrains that the memory contents can only be changed after specific command sequences have completed successfully.

In the following, there are several features to protect the system from the accidental write cycles during VCC power-up and power-down or from system noise.

• Power-on reset: to avoid sudden power switch by system power supply transition, the power-on reset may protect the Flash.

• Valid command length checking: The command length will be checked whether it is at byte base and completed on byte boundary.

• Write Enable (WREN) command: WREN command is required to set the Write Enable Latch bit (WEL) before issuing other commands to change data.

• Software Protection Mode: The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits define the section of the memory array that can be read but not change.

• Hardware Protection Mode: WP# going low to protected the BP0~BP4bits and SRP0~1bits

• Deep Power-Down Mode: By entering deep power down mode, the flash device is under protected from writing all commands except the Release from Deep Power-Down Mode command.

Table 3-1. Protected Area Sizes

TH25D-20UA Protected Area Sizes (CMP bit = 0)

	S	tatus b	it		Memory Content				
BP4	BP3	BP2	BP1	BP0	Blocks	Addresses	Density	Portion	
0	х	х	0	0	NONE	NONE	NONE	NONE	
0	0	х	0	1	3	030000H-03FFFFH	64KB	Upper 1/4	
0	0	х	1	0	2 and 3	020000H-03FFFFH	128KB	Upper 1/2	
0	1	х	0	1	0	000000H-00FFFFH	64KB	Lower 1/4	
0	1	х	1	0	0 and 1	000000H-01FFFFH	128KB	Lower 1/2	
0	Х	х	1	1	0 to 3	000000H-03FFFFH	256KB	ALL	
1	х	0	0	0	NONE	NONE	NONE	NONE	
1	0	0	0	1	3	03F000H-03FFFFH	4KB	Upper 1/64	
1	0	0	1	0	3	03E000H-03FFFFH	8KB	Upper 1/32	
1	0	0	1	1	3	03C000H-03FFFFH	16KB	Upper 1/16	
1	0	1	0	х	3	038000H-03FFFFH	32KB	Upper 1/8	
1	0	1	1	0	3	038000H-03FFFFH	32KB	Upper 1/8	
1	1	0	0	1	0	000000H-000FFFH	4KB	Lower 1/64	
1	1	0	1	0	0	000000H-001FFFH	8KB	Lower 1/32	
1	1	0	1	1	0	000000H-003FFFH	16KB	Lower 1/16	
1	1	1	0	х	0	000000H-007FFFH	32KB	Lower 1/8	
1	1	1	1	0	0	000000H-007FFFH	32KB	Lower 1/8	
1	х	1	1	1	0 to 3	000000H-03FFFFH	256KB	ALL	

TH25D-20UA Protected Area Sizes (CMP bit = 1)

Status bit Memory Content								
BP4	BP3	BP2	BP1	BP0	Blocks	Addresses	Density	Portion
0	х	x	0	0	0 to 3	000000H-03FFFFH	256KB	ALL
0	0	x	0	1	0 to 2	000000H-02FFFFH	192KB	Lower 3/4
0	0	x	1	0	0 and1	000000H-01FFFFH	128KB	Lower 1/2
0	1	х	0	1	1 to 3	010000H-03FFFFH	192KB	Upper 3/4
0	1	х	1	0	2 and 3	020000H-03FFFFH	128KB	Upper 1/2
0	x	х	1	1	NONE	NONE	NONE	NONE
1	х	0	0	0	0 to 3	000000H-03FFFFH	256KB	ALL
1	0	0	0	1	0 to 3	000000H-03EFFFH	252KB	Lower 63/64
1	0	0	1	0	0 to 3	000000H-03DFFFH	248KB	Lower 31/32
1	0	0	1	1	0 to 3	000000H-03BFFFH	240KB	Lower 15/16
1	0	1	0	х	0 to 3	000000H-037FFFH	224KB	Lower 7/8
1	0	1	1	0	0 to 3	000000H-037FFFH	224KB	Lower 7/8
1	1	0	0	1	0 to 3	001000H-03FFFFH	252KB	Upper 63/64
1	1	0	1	0	0 to 3	002000H-03FFFFH	248KB	Upper 31/32
1	1	0	1	1	0 to 3	004000H-03FFFFH	240KB	Upper 15/16
1	1	1	0	х	0 to 3 008000H-03FFFH		224KB	Upper 7/8
1	1	1	1	0	0 to 3	008000H-03FFFFH	224KB	Upper 7/8
1	х	1	1	1	NONE	NONE	NONE	NONE

Note:

1. X=don't care

2. If any erase or program command specifies a memory that contains protected data portion, this command will be ignored.

4. Electrical Specifications

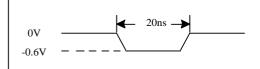
4.1. Absolute Maximum Ratings

Parameters	Value
Storage Temperature	-65°C to +150°C
Operation Temperature	-40°C to +85°C
Maximum Operation Voltage	4.0V
Voltage on Any Pin with respect to Ground	-0.6V to + 4.1V
DC Output Current	5.0 mA

NOTICE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Figure 4-1 Maximum Overshoot Waveform

Maxinum Negative Overshoot Waveform



Maxinum Positive Overshoot Waveform

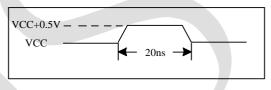


Table 4-1 Pin Capacitance [1]

Symbol	Parameter	Max.	Units	Test Condition
Соит	Output Capacitance	8	pF	V _{OUT} =GND
C _{IN}	Input Capacitance	6	pF	V _{IN} =GND

Note:

Test Conditions: $T_A = 25^{\circ}C$, F = 1MHz, Vcc = 3.0V.

Figure 4-2 Input Test Waveforms and Measurement Level

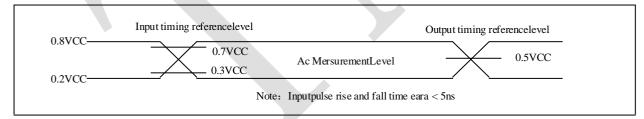
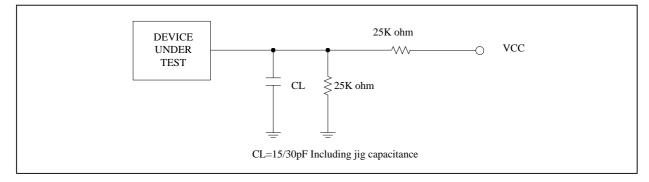


Figure 4-3 Output Loading



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4.2.DC Characteristics

Table 4-2 DC parameters

Curre	Deventer	Conditions	1.0	65V to 3	3.6V	2.3	3V to 3.	6V	Units
Sym.	Parameter	Conditions	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
I _{DPD}	Deep power down current	CS#=Vcc, all other inputs at 0V or Vcc		0.1	1.5		0.5	1.5	uA
I _{SB}	Standby current	CS#, WP#=VIH all inputs at CMOS levels		9			10		uA
	Low power read	f=33MHz; IOUT=0mA		0.6	1.2		0.6	1.2	mA
I _{CC1}	current (03h)	f=55MHz; IOUT=0mA					1.4	2.0	mA
	Read current (0Bh)	f=85MHz; IOUT=0mA		1.4	2.0		1.7	2.0	mA
I _{CC2}	Keau current (OBH)	f=100MHz; IOUT=0mA			ł		1.7	2.5	mA
I _{CC3}	Program current	CS#=Vcc		1.5	2.5		2.3	3.0	mA
I _{CC4}	Erase current	CS#=Vcc		1.5	2.5		2.3	3.0	mA
I _{LI}	Input load current	All inputs at CMOS level			1.0			1.0	uA
I _{LO}	Output leakage	All inputs at CMOS level			1.0			1.0	uA
V _{IL}	Input low voltage				0.2Vcc			0.3Vcc	V
V _{IH}	Input high voltage		0.8Vcc			0.7Vcc			V
V _{OL}	Output low voltage	IOL=100uA			0.2			0.2	V
V _{OH}	Output high voltage	IOH=-100uA	Vcc-0.2			Vcc-0.2			V

Note:

1. Typical values measured at 1.8V @ 25°C for the 1.65V to 3.6V range.

2. Typical values measured at 3.0V @ 25°C for the 2.3V to 3.6V range.

4.3.AC Characteristics

Table 4-3 AC parameters

Cumbal	Alt.	Devenueder	1	.65V~3.0	δV	2	.3V~3.6		
Symbol	Alt.	Parameter	min		max	min	typ	max	Unit
		Clock Frequency for the following							
fSCLK	fC	instructions: FAST_READ, RDSFDP, PP, SE, BE32K,	D.C.		85			100	MHz
		BE, CE, DP, RES,							
fRSCLK	fR	Clock Frequency for READ instructions			33			55	MHz
fTSCLK	fT	Clock Frequency for 2READ,DREAD instructions			85			100	MHz
tCH(1)	tCLH	Clock High Time	5.5			4.5			ns
tCL(1)	tCLL	Clock Low Time (fSCLK) 45% x (1fSCLK)	5.5			4.5			ns
tCLCH(7)		Clock Rise Time (peak to peak)	0.1			0.1			ns/v
tCHCL(7)		Clock Fall Time (peak to peak)	0.1			0.1			ns/v
tSLCH	tCSS	CS# Active Setup Time (relative to SCLK)	5			5			ns
tCHSL		CS# Not Active Hold Time (relative to SCLK)	5			5			ns
tDVCH	tDSU	Data In Setup Time	2			2			ns
tCHDX	tDH	Data In Hold Time	3			3			ns
tCHSH		CS# Active Hold Time (relative to SCLK)	5			5			ns
tSHCH		CS# Not Active Setup Time (relative to SCLK)	5			5			ns
		CS# Deselect Time From Read to next Read	15			15			ns
tSHSL	tCSH	CS# Deselect Time From Write,Erase,Program to Read Status Register	30			30			ns
tSHQZ(7)	tDIS	Output Disable Time			6			6	ns
10101/		Clock Low to Output Valid Loading 30pF			7			7	ns
tCLQV	tV	Clock Low to Output Valid Loading 15pF			6			6	ns
tCLQX	tHO	Output Hold Time	0			0			ns
tWHSL(3)		Write Protect Setup Time	20			20			ns
tSHWL(3)		Write Protect Hold Time	100			100			ns
tDP		CS# High to Deep Power-down Mode			3			3	us
tRES1		CS# High To Standby Mode Without Electronic Signature Read			8			8	us
tRES2		CS# High To Standby Mode Without Electronic Signature Read			8			8	us
tW		Write Status Register Cycle Time		8	12		8	12	ms
tReady		Reset recovery time(for erase/program operation except WRSR)	35			35			us
		Reset recovery time(for WRSR operation)		8	12		8	12	ms

4.4. AC Characteristics for Program and Erase

Table 4-4 AC parameters for program and erase

Sym.	Parameter		Units		
	Falailletei	Min.	Тур.	Max.	Units
T _{ESL(6)}	Erase Suspend Latency			30	us
T _{PSL(6)}	Program Suspend Latency			30	us
T _{PRS(4)}	Latency between Program Resume and next Suspend	10			us
T _{ERS(5)}	Latency between Erase Resume and next Suspend	10			us
t _{PP}	Page program time (up to 256 bytes)		1.3	1.6	ms
t _{PE}	Page erase time		10	12	ms
t _{se}	Sector erase time		10	12	ms
t _{BE1}	Block erase time for 32K bytes		10	12	ms
t_{BE2}	Block erase time for 64K bytes		10	12	ms
t _{CE}	Chip erase time		10	12	ms

Note:

1. tCH + tCL must be greater than or equal to 1/ Frequency.

2. Typical values given for TA=25°C. Not 100% tested.

3. Only applicable as a constraint for a WRSR instruction.

4. Program operation may be interrupted as often as system request. The minimum timing of tPRS must be

observed before issuing the next program suspend command. However, in order for an Program operation to make progress, tPRS \geq 100us must be included in resume-to-suspend loop(s). Not 100% tested.

5. Erase operation may be interrupted as often as system request. The minimum timing of tERS must be observed before issuing the next erase suspend command. However, in order for an Erase operation to make progress, tERS \geq 200us must be included in resume-to-suspend loop(s). Notes: Not 100% tested.

6. Latency time is required to complete Erase/Program Suspend operation.

7. The value guaranteed by characterization, not 100% tested in production.

Figure 4-4 Serial Input Timing

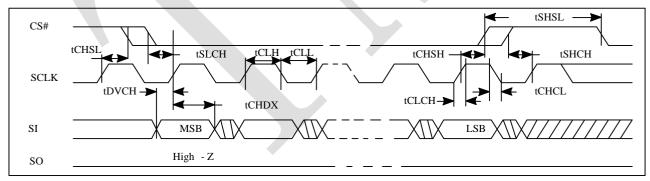




Figure 4-5 Output Timing

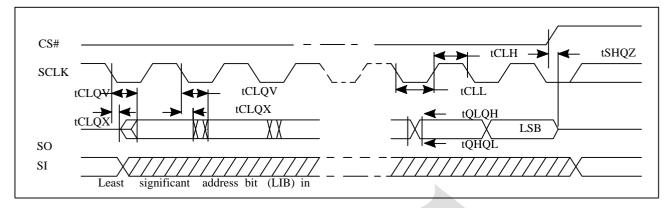
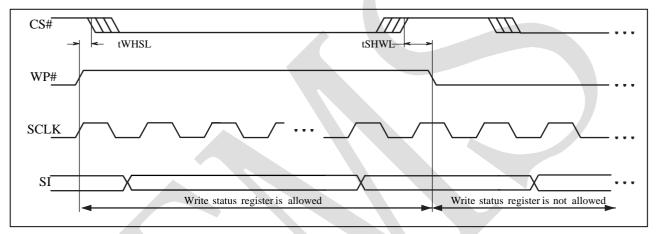


Figure 4-6 WP Timing



4.5. Operation Conditions

At Device Power-Up and Power-Down

AC timing illustrated in "Figure AC Timing at Device Power-Up" and "Figure Power-Down Sequence" are for the supply voltages and the control signals at device power-up and power-down. If the timing in the figures is ignored, the device will not operate correctly.

During power-up and power-down, CS# needs to follow the voltage applied on VCC to keep the device not to be selected. The CS# can be driven low when VCC reach Vcc(min.) and wait a period of tVSL.

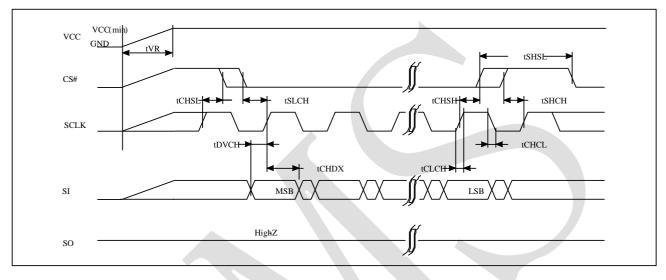
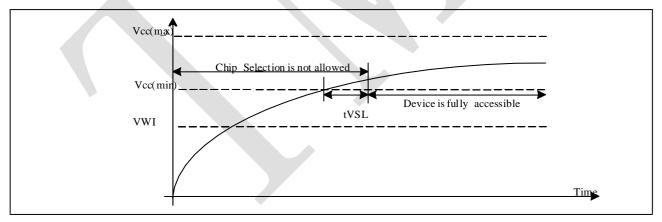


Figure 4-7 AC Timing at Device Power-Up

Figure 4-8 Power-Up Timing

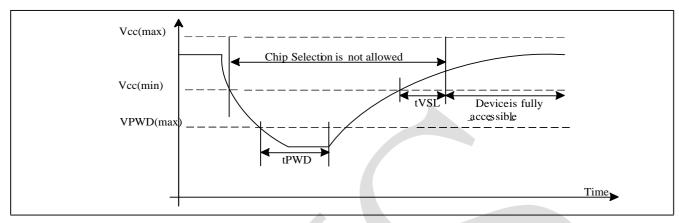


Power Up/Down and Voltage Drop

For Power-down to Power-up operation, the VCC of flash device must below VPWD for at least tPWD timing.

Please check the table below for more detail.

Figure 4-9 Power down-up Timing



Symbol	Parameter	min	max	unit
VPWD	VCC voltage needed to below VPWD for ensuring initialization will occur		1	V
tPWD	The minimum duration for ensuring initialization will occur	300		us
tVSL	VCC(min.) to device operation	70		us
tVR	VCC Rise Time	1	500000	us/V
VWI	Write Inhibit Voltage	1.45	1.55	V



5. Commands

5.1.Commands listing

Figure 5-1 Command set

Commands	Abbr.	Code	ADR Bytes	DMY Bytes	Data Bytes	Function description
Read						
Read Array (fast)	FREAD 0Bh		3	1	1+	n bytes read out until CS# goes high
Read Array (low power)	READ	03h	3	0	1+	n bytes read out until CS# goes high
Read Dual Output	DREAD	3Bh	3	1	1+	n bytes read out by Dual output
Read 2x I/O	2READ	BBh	3	1	1+	n bytes read out by 2 x I/O
Program and Erase						
Page Erase	PE	81h	3	0	0	erase selected page
Sector Erase (4K bytes)	SE	20h	3	0	0	erase selected sector
Block Erase (32K bytes)	BE32	52h	3	0	0	erase selected 32K block
Block Erase (64K bytes)	BE64	D8h	3	0	0	erase selected 64K block
Chip Erase	CE	60h	0	0	0	erase whole chip
		C7h	0	0	0	erase whole chip
Page Program	РР	02h	3	0	1+	program selected page
Dual-IN Page Program	2PP	A2h	3	0	1+	program selected page by Dual input
Program/Erase Suspend	PES	75h	0	0	0	suspend program/erase operation
		B0h	0	0	0	suspend program/erase operation
Program/Erase Resume	PER	7Ah	0	0	0	continue program/erase operation
		30h	0	0	0	continue program/erase operation
Protection						
Write Enable	WREN	06h	0	0	0	sets the (WEL) write enable latch bit
Write Disable	WRDI	04h	0	0	0	resets the (WEL) write enable latch bit
Volatile SR Write Enable	VWREN	50h	0	0	0	Write enable for volatile status register
Security	·					
Erase Security Registers	ERSCUR	44h	3	0	0	Erase security registers
Program Security Registers	PRSCUR	42h	3	0	1+	Program security registers
Read Security Registers	RDSCUR	48h	3	1	1+	Read value of security register
Status Register						
Read Status Register	RDSR	05h	0	0	1	read out status register
	RDSR2	35h	0	0	1	Read out status register-1
Active Status Interrupt	ASI	25h	0	1	0	Enable the active status interrupt
Write Status Register	WRSR	01h	0	0	2	Write data to status registers

Command set (Cont'd)

Commands	Abbr.	Code	ADR Bytes	DMY Bytes	Data Bytes	Function
Other Commands						
Reset Enable	RSTEN	66h	0	0	0	Enable reset
Reset	RST	99h	0	0	0	Reset
Read Manufacturer/device ID	RDID	9Fh	0	0	1 to 3	output JEDEC ID: 1-byte manufacturer ID & 2-byte device ID
Read Manufacture ID	REMS	90h	3		1+	Read manufacturer ID/device ID data
Dual Read Manufacture ID	DREMS	92h	3	1	1	Dual output read manufacture/device ID
Deep Power-down	DP	B9h	0	0	0	enters deep power-down mode
Release Deep Power-down / Read Electronic ID	RDP/RES	ABh	3	0	1	Read electronic ID data
Read SFDP	RDSFDP	5Ah				Read SFDP parameter
Release read enhanced		FFh				Release from read enhanced
Read unique ID	RUID	4Bh		4	1+	Read unique ID

NOTE:

1. Dual Output data

IO0 = (D6, D4, D2, D0)

IO1 = (D7, D5, D3, D1)

2. Dual Input Address

IO0 = A22, A20, A18, A16, A14, A12, A10, A8 A6, A4, A2, A0, M6, M4, M2, M0 IO1 = A23, A21, A19, A17, A15, A13, A11, A9 A7, A5, A3, A1, M7, M5, M3, M1

3. Security Registers Address:

Security Register1: A23-A16=00H, A15-A9=0001000, A8-A0= Byte Address;

Security Register2: A23-A16=00H, A15-A9=0010000, A8-A0= Byte Address;

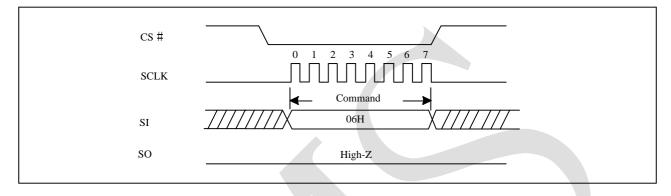
Security Register3: A23-A16=00H, A15-A9=0011000, A8-A0= Byte Address;

5.2. Write Enable (WREN)

The Write Enable (WREN) instruction is for setting Write Enable Latch (WEL) bit. For those instructions like PP,DPP, PE,SE, BE32K,BE, CE, and WRSR,ERSCUR, PRSCUR which are intended to change the device content, should be set every time after the WREN instruction setting the WEL bit.

The sequence of issuing WREN instruction is: CS# goes low \rightarrow sending WREN instruction code \rightarrow CS# goes high.

Figure 5-2 Write Enable (WREN) Sequence (Command 06)



5.3. Write Disable (WRDI)

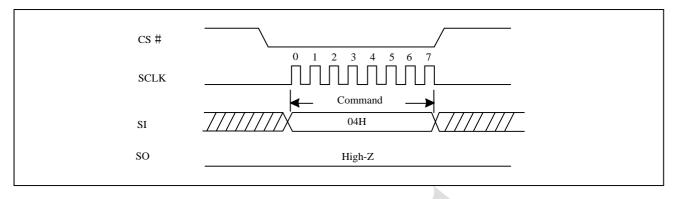
The Write Disable (WRDI) instruction is for resetting Write Enable Latch (WEL) bit.

The sequence of issuing WRDI instruction is: CS# goes low \rightarrow sending WRDI instruction code \rightarrow CS# goes high.

The WEL bit is reset by following situations:

- Power-up
- Write Disable (WRDI) instruction completion
- Write Status Register (WRSR) instruction completion
- Page Program (PP) instruction completion
- Dual Input Page Program (DPP) instruction completion
- Page Erase (PE) instruction completion
- Sector Erase (SE) instruction completion
- Block Erase (BE32K,BE) instruction completion
- Chip Erase (CE) instruction completion
- Erase Security Register (ERSCUR) instruction completion
- Program Security Register (PRSCUR) instruction completion
- Reset (RST) instruction completion

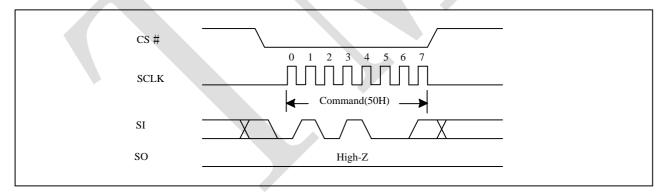
Figure 5-3 Write Disable (WRDI) Sequence (Command 04)



5.4. Write Enable for Volatile Status Register

The non-volatile Status Register bits can also be written to as volatile bits. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. The Write Enable for Volatile Status Register command must be issued prior to a Write Status Register command. The Write Enable for Volatile Status Register command will not set the Write Enable Latch bit, it is only valid for the Write Status Register command to change the volatile Status Register bit values.

The sequence of issuing Write Enable for Volatile Status Register instruction is: CS# goes low \rightarrow sending Write Enable for Volatile Status Register instruction code \rightarrow CS# goes high.





5.5. Read Status Register (RDSR)

The RDSR instruction is for reading Status Register Bits. The Read Status Register can be read at any time (even in program/erase/write status register condition). It is recommended to check the Write in Progress (WIP) bit before sending a new instruction when a program, erase, or write status register operation is in progress. For command code "05H", the SO will output Status Register bits S7~S0. The command code "35H", the SO will output Status Register bits S15~S8

The sequence of issuing RDSR instruction is: CS# goes low \rightarrow sending RDSR instruction code \rightarrow Status Register data out on SO.

The SIO[2:1] are "don't care".

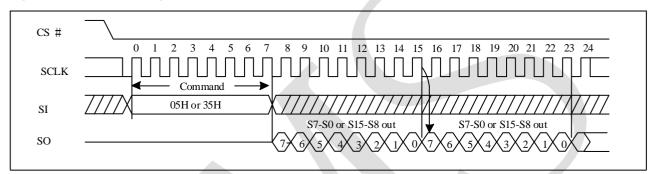


Figure 5-5 Read Status Register (RDSR) Sequence (Command 05 or 35)

5.6. Active Status Interrupt (ASI)

To simplify the readout of the WIP bit, the Active Status Interrupt command (25h) may be used. It is then not necessary to continuously read the status register, it is sufficient to monitor the value of the SO line. If the SO line is connected to an interrupt line on the host controller, the host controller may be in sleep mode until the SO line indicates that the device is ready for the next command.

The WIP bit can be read at any time, including during an internally self-timed program or erase operation. To enable the Active Status Interrupt command, the CS pin must first be asserted and the opcode of 25h must be clocked into the device. For SPI Mode0 and Mode3, at least one dummy bit has to be clocked into the device after the last bit of the opcode has been clocked in. (In most cases, this is most easily done by sending a dummy byte to the device.) The value of the SI line after the opcode is clocked in is of no significance to the operation.

The value of WIP is then output on the SO line, and is continuously updated by the device for as long as the CS pin remains asserted. Additional clocks on the SCLK pin are not required. For SPI Mode3, SCLK must keep low. If the WIP bit changes from 1 to 0 while the CS pin is asserted, the SO line will change from 1 to 0. (The WIP bit cannot change from 0 to 1 during an operation, so if the SO line already is 0, it will not change.)

Deasserting the CS pin will terminate the Active Status Interrupt operation and put the SO pin into a high-impedance state. The CS pin can be deasserted at any time and does not require that a full byte of data be read.

The sequence of issuing ASI instruction is: CS# goes low \rightarrow sending ASI instruction code \rightarrow WIP data out on SO.

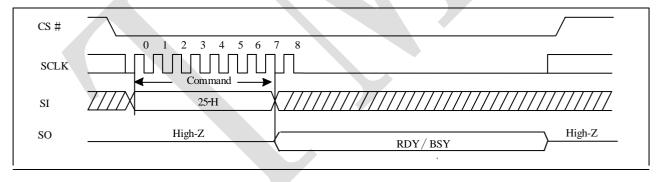


Figure 5-6 Active Status Interrupt (ASI) Sequence (Command 25)

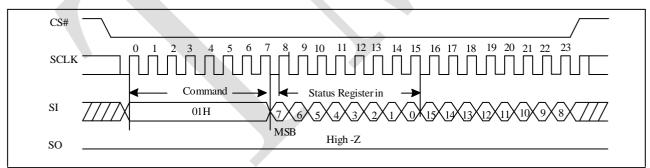
5.7. Write Status Register (WRSR)

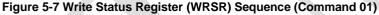
The Write Status Register (WRSR) command allows new values to be written to the Status Register. Before it can be accepted, a Write Enable (WREN) command must previously have been executed. After the Write Enable (WREN) command has been decoded and executed, the device sets the Write Enable Latch (WEL).

The Write Status Register (WRSR) command has no effect on S15, S10, S1 and S0 of the Status Register. CS# must be driven high after the eighth or sixteen bit of the data byte has been latched in. If not, the Write Status Register (WRSR) command is not executed. If CS# is driven high after eighth bit of the data byte, the CMP and SRP1 bits will not change. As soon as CS# is driven high, the self-timed Write Status Register cycle (whose duration is tW) is initiated. While the Write Status Register cycle is in progress, the Status Register may still be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Status Register cycle, and is 0 when it is completed. When the cycle is completed, the Write Enable Latch (WEL) is reset.

The Write Status Register (WRSR) command allows the user to change the values of the Block Protect (BP4, BP3, BP2, BP1, and BP0) bits, to define the size of the area that is to be treated as read-only, as defined in Table1. The Write Status Register (WRSR) command also allows the user to set or reset the Status Register Protect (SRP1 and SRP0) bits in accordance with the Write Protect (WP#) signal. The Status Register Protect (SRP1 and SRP0) bits and Write Protect (WP#) signal allow the device to be put in the Hardware Protected Mode. The Write Status Register (WRSR) command is not executed once the Hardware Protected Mode is entered.

The sequence of issuing WRSR instruction is: CS# goes low \rightarrow sending WRSR instruction code \rightarrow Status Register data on SI \rightarrow CS# goes high.The CS# must go high exactly at the 8 bits or 16 bits data boundary; otherwise, the instruction will be rejected and not executed. The self-timed Write Status Register cycle time (tW) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Write Status Register cycle is in progress. The WIP sets 1 during the tW timing, and sets 0 when Write Status Register Cycle is completed, and the Write Enable Latch (WEL) bit is reset.





5.8. Read Data Bytes (READ)

The read instruction is for reading data out. The address is latched on rising edge of SCLK, and data shifts out on the falling edge of SCLK at a maximum frequency fR. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single READ instruction. The address counter rolls over to 0 when the highest address has been reached.

The sequence of issuing READ instruction is: CS# goes low \rightarrow sending READ instruction code \rightarrow 3-byte address on SI \rightarrow data out on SO \rightarrow to end READ operation can use CS# to high at any time during data out.

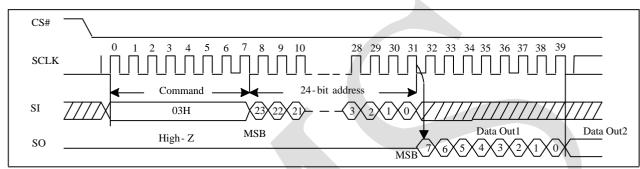


Figure 5-8 Read Data Bytes (READ) Sequence (Command 03)

5.9. Read Data Bytes at Higher Speed (FAST_READ)

The FAST_READ instruction is for quickly reading data out. The address is latched on rising edge of SCLK, and data of each bit shifts out on the falling edge of SCLK at a maximum frequency fC. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single FAST_READ instruction. The address counter rolls over to 0 when the highest address has been reached.

The sequence of issuing FAST_READ instruction is: CS# goes low \rightarrow sending FAST_READ instruction code \rightarrow 3-byte address on SI \rightarrow 1 -dummy byte address on SI \rightarrow data out on SO \rightarrow to end FAST_READ operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, FAST_READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

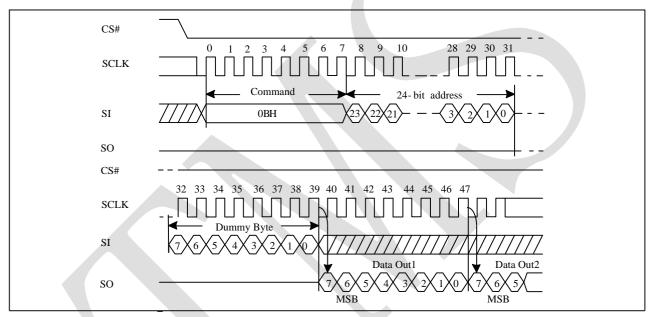


Figure 5-9 Read at Higher Speed (FAST_READ) Sequence (Command 0B)

5.10. Dual Read Mode (DREAD)

The DREAD instruction enable double throughput of Serial NOR Flash in read mode. The address is latched on rising edge of SCLK, and data of every two bits (interleave on 2 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fT. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single DREAD instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing DREAD instruction, the following data out will perform as 2-bit instead of previous 1-bit.

The sequence of issuing DREAD instruction is: CS# goes low \rightarrow sending DREAD instruction \rightarrow 3-byte address on SI \rightarrow 8-bit dummy cycle \rightarrow data out interleave on SIO1 & SIO0 \rightarrow to end DREAD operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, DREAD instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

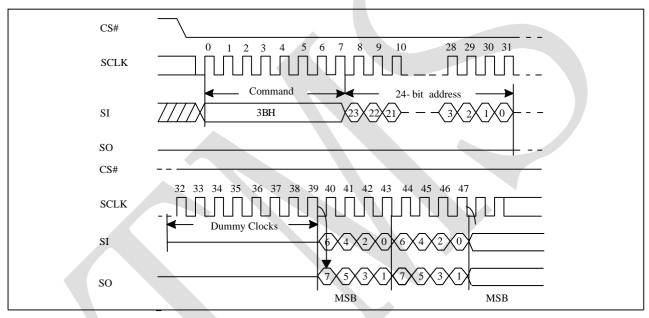


Figure 5-10 Dual Read Mode Sequence (Command 3B)

5.11.2 X IO Read Mode (2READ)

The 2READ instruction enables Double Transfer Rate of Serial NOR Flash in read mode. The address is latched on rising edge of SCLK, and data of every two bits (interleave on 2 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fT. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single 2READ instruction. The address counter rolls over to 0 when the highest address has been reached.

Once writing 2READ instruction, the following address/dummy/data out will perform as 2-bit instead of previous 1-bit.

The sequence of issuing 2READ instruction is: CS# goes low \rightarrow sending 2READ instruction \rightarrow 24-bit address interleave on SIO1 & SIO0 \rightarrow 8-bit dummy cycle on SIO1 & SIO0 \rightarrow data out interleave on SIO1 & SIO0 \rightarrow to end 2READ operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, 2READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

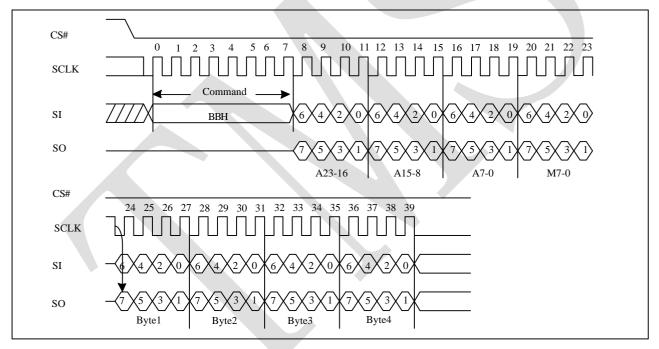
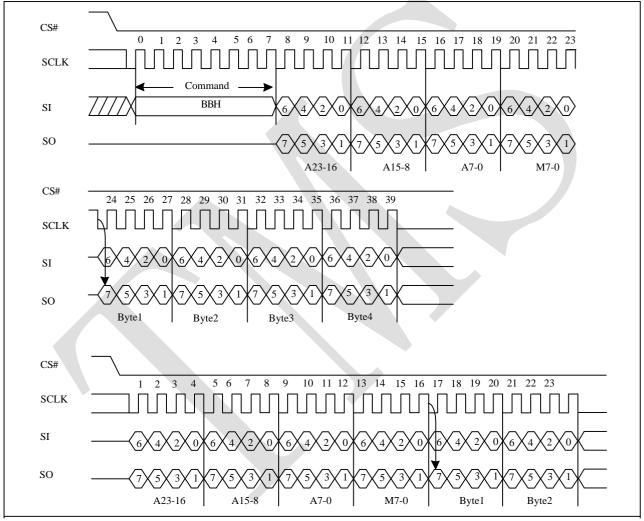


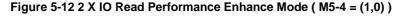
Figure 5-11 2 X IO Read Mode Sequence (Command BB M5-4 ≠ (1,0))

5.12.2 X IO Read Performer Enhance Mode

"BBh" command supports 2 X IO Performance Enhance Mode which can further reduce command overhead through setting the "Continuous Read Mode" bits (M7-0) after the input 3-byte address (A23-A0). If the "Continuous Read Mode" bits (M5-4) = (1, 0), then the next 2 X IO Read command (after CS# is raised and then lowered) does not require the BBH command code.

If the "Continuous Read Mode" bits (M5-4) do not equal (1, 0), the next command requires the first BBH command code, thus returning to normal operation. A "Continuous Read Mode" Reset command can be used to reset (M5-4) before issuing normal command.





Note:

2 X IO Read Performance Enhance Mode, if M5-4 = 1, 0. If not using performance enhance recommend to set M5-4 \neq 1, 0.

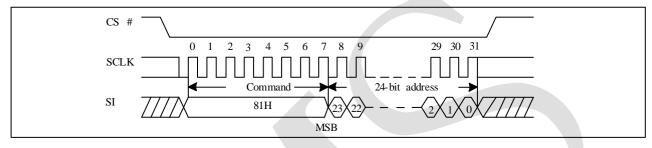
5.13. Page Erase (PE)

The Page Erase (PE) instruction is for erasing the data of the chosen Page to be "1". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Page Erase (PE).

To perform a Page Erase with the standard page size (256 bytes), an opcode of 81h must be clocked into the device followed by three address bytes comprised of 2 page address bytes that specify the page in the main memory to be erased, and 1 dummy byte.

The sequence of issuing PE instruction is: CS# goes low \rightarrow sending PE instruction code \rightarrow 3-byte address on SI \rightarrow CS# goes high





5.14. Sector Erase (SE)

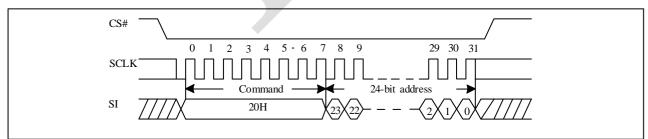
The Sector Erase (SE) instruction is for erasing the data of the chosen sector to be "1". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Sector Erase (SE). Any address of the sector is a valid address for Sector Erase (SE) instruction. The CS# must go high exactly at the byte boundary (the latest eighth of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

Address bits [Am-A12] (Am is the most significant address) select the sector address.

The sequence of issuing SE instruction is: CS# goes low \rightarrow sending SE instruction code \rightarrow 3-byte address on SI \rightarrow CS# goes high.

The SIO[2:1] are don't care.

Figure 5-14 Sector Erase (SE) Sequence (Command 20)



The self-timed Sector Erase Cycle time (tSE) is initiated as soon as Chip Select (CS#) goes high. The Write in progress (WIP) bit still can be check out during the Sector Erase cycle is in progress. The WIP sets 1 during the tSE timing, and sets 0 when Sector Erase Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If the sector is protected by BP4, BP3, BP2, BP1, BP0 bits, the Sector Erase (SE) instruction will



not be executed on the sector.

5.15. Block Erase (BE32K)

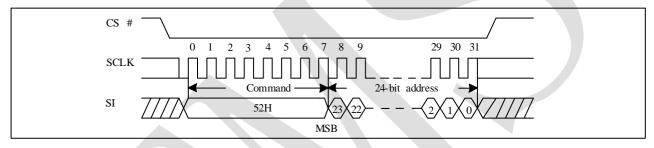
The Block Erase (BE32K) instruction is for erasing the data of the chosen block to be "1". The instruction is used for 32K-byte block erase operation. A Write Enable (WREN) instruction must be executed to set the Write Enable Latch (WEL) bit before sending the Block Erase (BE32K). Any address of the block is a valid address for Block Erase (BE32K) instruction. The CS# must go high exactly at the byte boundary (the least significant bit of address byte has been latched-in); otherwise, the instruction will be rejected and not executed.

The sequence of issuing BE32K instruction is: CS# goes low \rightarrow sending BE32K instruction code \rightarrow 3-byte address on SI \rightarrow CS# goes high.

The SIO[2:1] are don't care.

The self-timed Block Erase Cycle time (tBE32K) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked while the Block Erase cycle is in progress. The WIP sets during the tBE32K timing, and clears when Block Erase Cycle is completed, and the Write Enable Latch (WEL) bit is cleared. If the block is protected by BP4, BP3, BP2, BP1,BP0 bits, the array data will be protected (no change) and the WEL bit still be reset.

Figure 5-15 Block Erase 32K(BE32K) Sequence (Command 52)



5.16. Block Erase (BE)

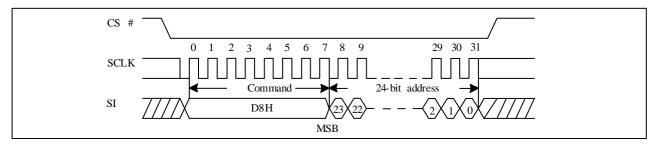
The Block Erase (BE) instruction is for erasing the data of the chosen block to be "1". The instruction is used for 64K-byte block erase operation. A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Block Erase (BE). Any address of the block is a valid address for Block Erase (BE) instruction. The CS# must go high exactly at the byte boundary (the latest eighth of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

The sequence of issuing BE instruction is: CS# goes low \rightarrow sending BE instruction code \rightarrow 3-byte address on SI \rightarrow CS# goes high.

The SIO[2:1] are "don't care".

The self-timed Block Erase Cycle time (tBE) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Block Erase cycle is in progress. The WIP sets 1 during the tBE timing, and sets 0 when Block Erase Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If the block is protected by BP4, BP3, BP2, BP1, BP0 bits, the Block Erase (BE) instruction will not be executed on the block.

Figure 5-16 Block Erase (BE) Sequence (Command D8)



5.17. Chip Erase (CE)

The Chip Erase (CE) instruction is for erasing the data of the whole chip to be "1". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Chip Erase (CE). The CS# must go high exactly at the byte boundary (the latest eighth of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

The sequence of issuing CE instruction is: CS# goes low \rightarrow sending CE instruction code \rightarrow CS# goes high. The SIO[2:1] are "don't care".

The self-timed Chip Erase Cycle time (tCE) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Chip Erase cycle is in progress. The WIP sets 1 during the tCE timing, and sets 0 when Chip Erase Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If the chip is protected by BP4,BP3, BP2, BP1, BP0 bits, the Chip Erase (CE) instruction will not be executed. It will be only executed when all Block Protect(BP4, BP3, BP2, BP1, BP0) are set to "None protected".

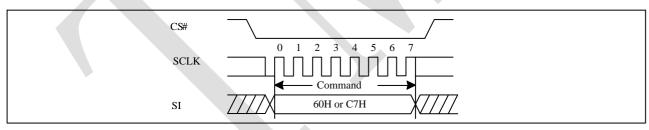


Figure 5-17 Chip Erase (CE) Sequence (Command 60 or C7)

5.18. Page Program (PP)

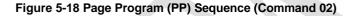
The Page Program (PP) instruction is for programming the memory to be "0". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Page Program (PP). The device programs only the last 256 data bytes sent to the device. If the entire 256 data bytes are going to be programmed, A7-A0 (The eight least significant address bits) should be set to 0. If the eight least significant address bits (A7-A0) are not all 0, all transmitted data going beyond the end of the current page are programmed from the start address of the same page (from the address A7-A0 are all 0). If more than 256 bytes are sent to the device, the data of the last 256-byte is programmed at the request page and previous data will be disregarded. If less than 256 bytes are sent to the device, the data is programmed at the requested address of the page without effect on other address of the same page.

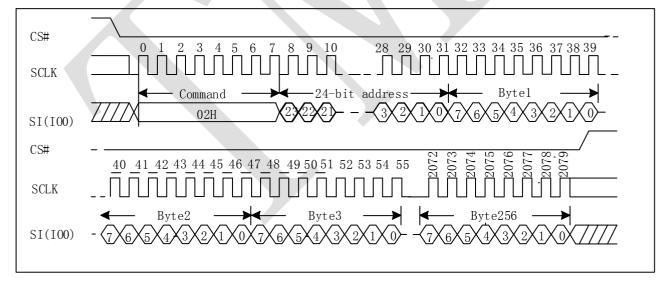
The sequence of issuing PP instruction is: CS# goes low \rightarrow sending PP instruction code \rightarrow 3-byte address on SI \rightarrow at least 1-byte on data on SI \rightarrow CS# goes high.

The CS# must be kept low during the whole Page Program cycle; The CS# must go high exactly at the byte boundary (the latest eighth bit of data being latched in), otherwise the instruction will be rejected and will not be executed.

The self-timed Page Program Cycle time (tPP) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Page Program cycle is in progress. The WIP sets 1 during the tPP timing, and sets 0 when Page Program Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If the page is protected by BP4, BP3, BP2, BP1, BP0 bits, the Page Program (PP) instruction will not be executed.

The SIO[2:1] are "don't care".





5.19. Dual Input Page Program (DPP)

The Dual Input Page Program (DPP) instruction is similar to the standard Page Program command and can be used to program anywhere from a single byte of data up to 256 bytes of data into previously erased memory locations. The Dual-Input Page Program command allows two bits of data to be clocked into the device on every clock cycle rather than just one.

A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Dual Input Page Program (DPP). The Dual Input Page Programming takes two pins: SIO0, SIO1 as data input, which can improve programmer performance and the effectiveness of application. The other function descriptions are as same as standard page program.

The sequence of issuing DPP instruction is: CS# goes low \rightarrow sending DPP instruction code \rightarrow 3-byte address on SI \rightarrow at least 1-byte on data on SIO[1:0] \rightarrow CS# goes high.

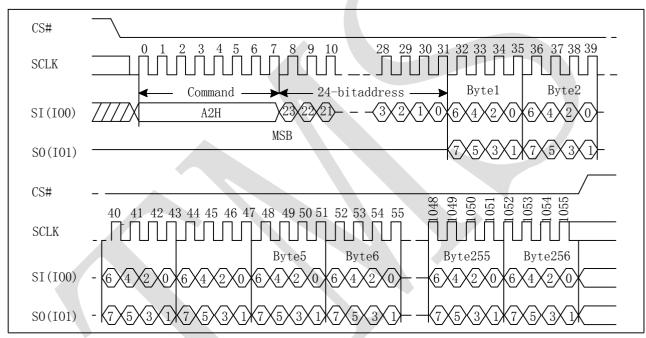


Figure 5-19 Page Program (DPP) Sequence (Command A2)

5.20. Erase Security Registers (ERSCUR)

The product provides three 512-byte Security Registers which can be erased and programmed individually. These registers may be used by the system manufacturers to store security and other important information separately from the main memory array.

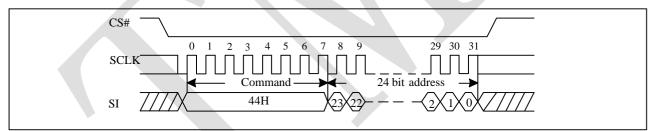
The Erase Security Registers command is similar to Sector/Block Erase command, the instruction is used for 512-byte erase operation. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit.

The Erase Security Registers command sequence: CS# goes low \rightarrow sending ERSCUR instruction \rightarrow sending 24 bit address \rightarrow CS# goes high.

CS# must be driven high after the eighth bit of the command code has been latched in; otherwise the Erase Security Registers command is not executed. As soon as CS# is driven high, the self-timed Erase Security Registers cycle (whose duration is tSE) is initiated. While the Erase Security Registers cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Erase Security Registers cycle, and is 0 when it is completed. The Security Registers Lock Bit (LB3-1) in the Status Register can be used to OTP protect the security registers. Once the LB bit is set to 1, the Security Registers will be permanently locked; the Erase Security Registers command will be ignored.

Address	A23-16	A15-12	A11-9	A8-0
Security Register #1	00H	0001	000	Don't care
Security Register #2	00H	0010	000	Don't care
Security Register #3	00H	0011	000	Don't care

Figure 5-20 Erase Security Registers (ERSCUR) Sequence (Command 44)





5.21. Program Security Registers (PRSCUR)

The Program Security Registers command is similar to the Page Program command. It allows from 1 to 512bytes Security Registers data to be programmed. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Program Security Registers command.

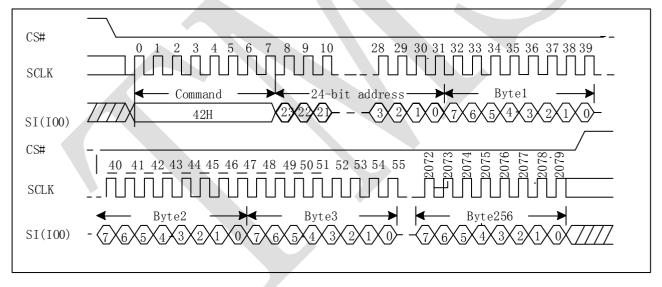
The Program Security Registers command sequence: CS# goes low \rightarrow sending PRSCUR instruction \rightarrow sending 24 bit address \rightarrow sending at least one byte data \rightarrow CS# goes high.

As soon as CS# is driven high, the self-timed Program Security Registers cycle (whose duration is tPP) is initiated. While the Program Security Registers cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Program Security Registers cycle, and is 0 when it is completed.

If the Security Registers Lock Bit (LB3-1) is set to 1, the Security Registers will be permanently locked. Program Security Registers command will be ignored.

Address	A23-16	A15-12	A11-9	A8-0
Security Register #1	00H	0001	000	Byte Address
Security Register #2	00H	0010	000	Byte Address
Security Register #3	00H	0011	000	Byte Address



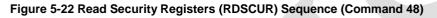


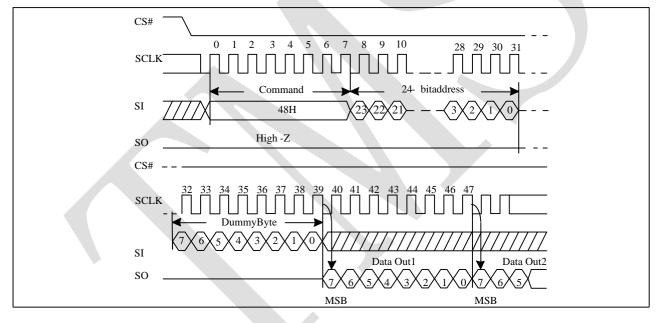
5.22. Read Security Registers (RDSCUR)

The Read Security Registers command is similar to Fast Read command. The command is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of SCLK. Then the memory content, at that address, is shifted out on SO, each bit being shifted out, at a Max frequency fC, during the falling edge of SCLK. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. Once the A8-A0 address reaches the last byte of the register (Byte 1FFH), it will reset to 000H, the command is completed by driving CS# high.

The sequence of issuing RDSCUR instruction is : CS# goes low \rightarrow sending RDSCUR instruction \rightarrow sending 24bit address \rightarrow 8 bit dummy byte \rightarrow Security Register data out on SO \rightarrow CS# goes high.

Address	A23-16	A15-12	A11-9	A8-0
Security Register #1	00H	0001	000	Byte Address
Security Register #2	00H	0010	000	Byte Address
Security Register #3	00H	0011	000	Byte Address





5.23. Deep Power-down (DP)

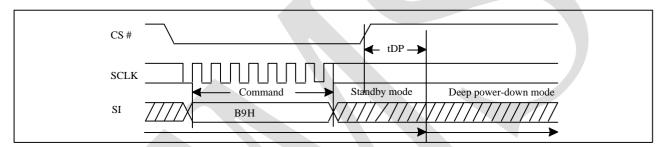
The Deep Power-down (DP) instruction is for setting the device on the minimizing the power consumption (to entering the Deep Power-down mode), the standby current is reduced from ISB1 to ISB2). The Deep

Power-down mode requires the Deep Power-down (DP) instruction to enter, during the Deep Power-down mode, the device is not active and all Write/Program/Erase instruction are ignored. When CS# goes high, it's only in standby mode not deep power-down mode.It's different from Standby mode.

The sequence of issuing DP instruction is: CS# goes low \rightarrow sending DP instruction code \rightarrow CS# goes high.

Once the DP instruction is set, all instruction will be ignored except the Release from Deep Power-down mode (RDP) and Read Electronic Signature (RES) instruction. (RES instruction to allow the ID been read out). When Power- down, the deep power-down mode automatically stops, and when power-up, the device automatically is in standby mode. For RDP instruction the CS# must go high exactly at the byte boundary (the latest eighth bit of instruction code been latched-in); otherwise, the instruction will not be executed. As soon as Chip Select (CS#) goes high, a delay of tDP is required before entering the Deep Power-down mode and reducing the current to ISB2.

Figure 5-23 Deep Power-down (DP) Sequence (Command B9)



5.24. Release form Deep Power-Down (RDP), Read Electronic Signature (RES)

The Release from Deep Power-down (RDP) instruction is terminated by driving Chip Select (CS#) High. When Chip Select (CS#) is driven high, the device is put in the Stand-by Power mode. If the device was not previously in the Deep Power-down mode, the transition to the Stand-by Power mode is immediate. If the device was previously in the Deep Power-down mode, though, the transition to the Stand-by Power mode is delayed by tRES2, and Chip Select (CS#) must remain High for at least tRES2(max). Once in the Stand-by Power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

RES instruction is for reading out the old style of 8-bit Electronic Signature, whose values are shown as table of ID Definitions. This is not the same as RDID instruction. It is not recommended to use for new design. For new design, please use RDID instruction. Even in Deep power-down mode, the RDP and RES are also allowed to be executed, only except the device is in progress of program/erase/write cycle; there's no effect on the current program/erase/ write cycle in progress.

The RES instruction is ended by CS# goes high after the ID been read out at least once. The ID outputs repeatedly if continuously send the additional clock cycles on SCLK while CS# is at low. If the device was not previously in Deep Power-down mode, the device transition to standby mode is immediate. If the device was previously in Deep Power-down mode, there's a delay of tRES2 to transit to standby mode, and CS# must remain to high at least tRES2 (max). Once in the standby mode, the device waits to be selected, so it can be receive, decode, and execute instruction.

The RDP instruction is for releasing from Deep Power-Down Mode.

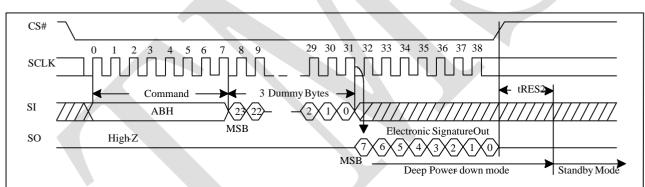
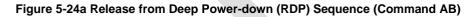
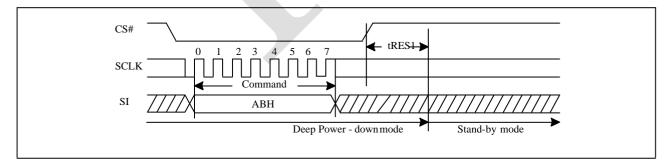


Figure 5-24 Read Electronic Signature (RES) Sequence (Command AB)



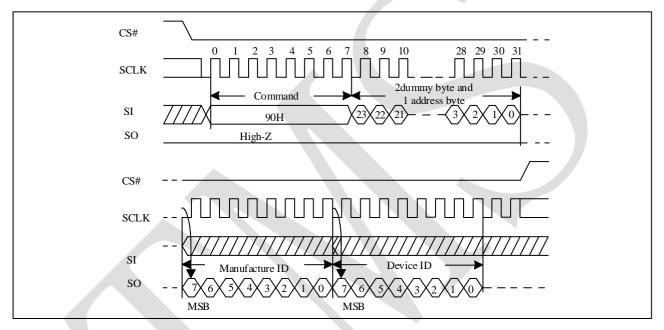


5.25. Read Electronic Manufacturer ID & Device ID (REMS)

The REMS instruction returns both the JEDEC assigned manufacturer ID and the device ID. The Device ID values are listed in "Table ID Definitions".

The REMS instruction is initiated by driving the CS# pin low and sending the instruction code "90h" followed by two dummy bytes and one address byte (A7~A0). After which the manufacturer ID for TMC (EBh) and the device ID are shifted out on the falling edge of SCLK with the most significant bit (MSB) first. If the least significant bit (LSB) of the address byte is 0b, the manufacturer ID will be output first, followed by the device ID. If the least significant bit (LSB) of the address byte is 1b, then the device ID will be output first, followed by the manufacturer ID. While CS# is low, the manufacturer and device IDs can be read continuously, alternating from one to the other. The instruction is completed by driving CS# high.





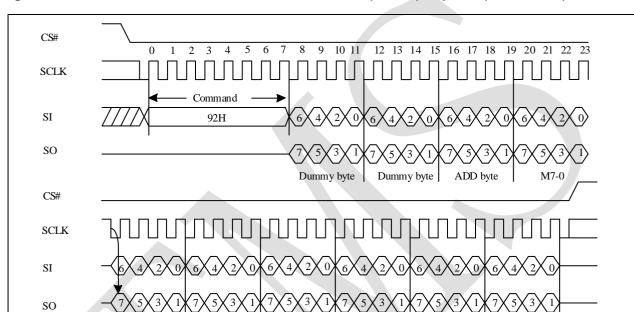
Manufacture ID

Device ID

5.26. Dual I/O Read Electronic Manufacturer ID & Device ID (DREMS)

The DREMS instruction is similar to the REMS command and returns the JEDEC assigned manufacturer ID which takes two pins: SIO0, SIO1 as address input and ID output I/O

The instruction is initiated by driving the CS# pin low and shift the instruction code "92h" followed by two dummy bytes and one bytes address (A7~A0). After which, the Manufacturer ID for TMC (EBh) and the Device ID are shifted out on the falling edge of SCLK with most significant bit (MSB) first. If the least significant bit (LSB) of the one-byte address is initially set to 1b, then the device ID will be read first and then followed by the Manufacturer ID. The Manufacturer and Device IDs can be read continuously, alternating from one to the other. The instruction is completed by driving CS# high.



Manufacture ID

(repeat)

Device ID

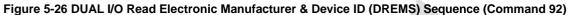
(repeat)

Manufacture ID

(repeat)

Device ID

(repeat)

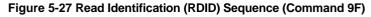


5.27. Read Identification (RDID)

The RDID instruction is for reading the manufacturer ID of 1-byte and followed by Device ID of 2-byte. The TMC Manufacturer ID and Device ID are list as "as "Table . ID Definition".

The sequence of issuing RDID instruction is: CS# goes low \rightarrow sending RDID instruction code \rightarrow 24-bits ID data out on SO \rightarrow to end RDID operation can use CS# to high at any time during data out.

While Program/Erase operation is in progress, it will not decode the RDID instruction, so there's no effect on the cycle of program/erase operation which is currently in progress. When CS# goes high, the device is at standby stage.



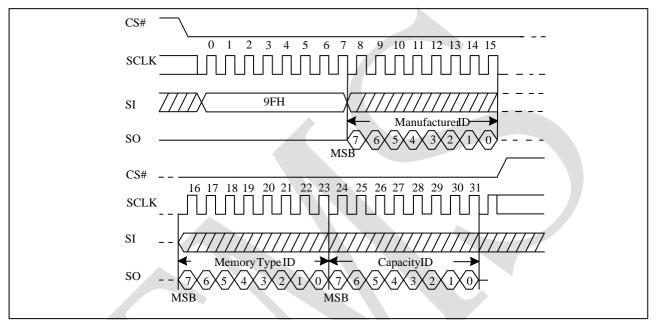


Table ID Definitions

	RDID	manufacturer ID	memory type	memory density
	command	EB	60	12
TH25D-20	RES	electronic ID		
UA	command	11		
	REMS	manufacturer ID device ID		
	command	E	11	

5.28. Program/Erase Suspend/Resume

The Suspend instruction interrupts a Page Program, Sector Erase, or Block Erase operation to allow access to the memory array. After the program or erase operation has entered the suspended state, the memory array can be read except for the page being programmed or the sector or block being erased.

Suspended Operation	Readable Region of Memory Array		
Page Program	All but the Page being programmed		
Page Erase	All but the Page being erased		
Sector Erase(4KB)	All but the 4KB Sector being erased		
Block Erase(32KB)	All but the 32KB Block being erased		
Block Erase(64KB)	All but the 64KB Block being erased		

Readable Area of Memory While a Program or Erase Operation is Suspended

When the Serial NOR Flash receives the Suspend instruction, there is a latency of tPSL or tESL before the Write Enable Latch (WEL) bit clears to "0" and the SUS2 or SUS1 sets to "1", after which the device is ready to accept one of the commands listed in "Table Acceptable Commands During Program/Erase Suspend after tPSL/tESL" (e.g. FAST READ). Refer to " AC Characteristics" for tPSL and tESL timings. "Table Acceptable Commands During Suspend (tPSL/tESL not required)" lists the commands for which the tPSL and tESL latencies do not apply. For example, RDSR, RDSCUR, RSTEN, and RST can be issued at any time after the Suspend instruction.

Status Register bit 15 (SUS2) and bit 10 (SUS1) can be read to check the suspend status. The SUS2 (Program Suspend Bit) sets to "1" when a program operation is suspended. The SUS1 (Erase Suspend Bit) sets to "1" when an erase operation is suspended. The SUS2 or SUS1 clears to "0" when the program or erase operation is resumed.

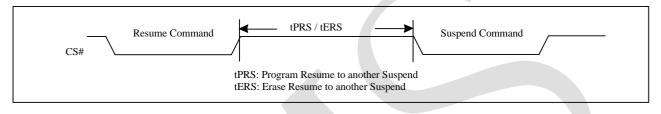
Command name	Command Code	Susper	nd Type
		Program Suspend	Erase Suspend
READ	03H	•	•
FAST READ	0BH	•	•
DREAD	3BH	•	•
2READ	BBH	•	•
RDSFDP	5AH	•	•
RDID	9FH	•	•
REMS	90H	•	•
DREMS	92H	•	•
RDSCUR	48H	•	•
SBL	77H	•	•
WREN	06H		•
RESUME	7AH OR 30H	•	•
PP	02H		•
DPP	A2H		•

Acceptable Commands During Program/Erase Suspend after tPSL/tESL

Command name	Command Code	Suspend Type	
		Program Suspend	Erase Suspend
WRDI	04H	•	•
RDSR	05H	•	•
RDSR2	35H	•	•
ASI	25H	•	•
RES	ABH	•	•
RSTEN	66H	•	•
RST	99H	•	•
NOP	00H	•	•

Acceptable Commands During Suspend (tPSL/tESL not required)

Figure 5-28 Resume to Suspend Latency

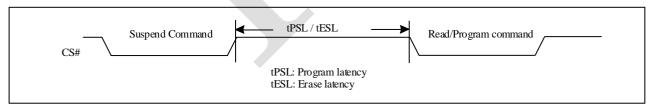


5.29. Erase Suspend to Program

The "Erase Suspend to Program" feature allows Page Programming while an erase operation is suspended. Page Programming is permitted in any unprotected memory except within the sector of a suspended Sector Erase operation or within the block of a suspended Block Erase operation. The Write Enable (WREN) instruction must be issued before any Page Program instruction.

A Page Program operation initiated within a suspended erase cannot itself be suspended and must be allowed to finish before the suspended erase can be resumed. The Status Register can be polled to determine the status of the Page Program operation. The WEL and WIP bits of the Status Register will remain "1" while the Page Program operation is in progress and will both clear to "0" when the Page Program operation completes.

Figure 5-29 Suspend to Read/Program Latency



Notes:

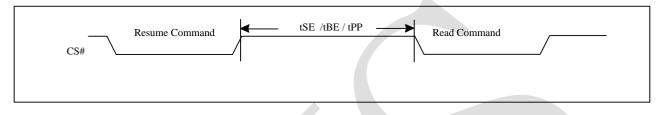
- 1. Please note that Program only available after the Erase-Suspend operation
- 2. To check suspend ready information, please read status register bit15 (SUS2) and bit10(SUS1)

5.30. Program Resume and Erase Resume

The Resume instruction resumes a suspended Page Program, Sector Erase, or Block Erase operation. Before issuing the Resume instruction to restart a suspended erase operation, make sure that there is no Page Program operation in progress.

Immediately after the Serial NOR Flash receives the Resume instruction, the WEL and WIP bits are set to "1" and the SUS2 or SUS1 is cleared to "0". The program or erase operation will continue until finished ("Resume to Read Latency") or until another Suspend instruction is received. A resume-to-suspend latency of tPRS or tERS must be observed before issuing another Suspend instruction ("Resume to Suspend Latency").

Figure 5-30 Resume to Read Latency



5.31. No Operation (NOP)

The "No Operation" command is only able to terminate the Reset Enable (RSTEN) command and will not affect any other command.

The SIO[2:1] are don't care.

5.32. Software Reset (RSTEN/RST)

The Software Reset operation combines two instructions: Reset-Enable (RSTEN) command and Reset (RST) command. It returns the device to a standby mode. All the volatile bits and settings will be cleared then, which makes the device return to the default status as power on.

To execute Reset command (RST), the Reset-Enable (RSTEN) command must be executed first to perform the Reset operation. If there is any other command to interrupt after the Reset-Enable command, the Reset-Enable will be invalid.

The SIO[2:1] are "don't care".

If the Reset command is executed during program or erase operation, the operation will be disabled, the data under processing could be damaged or lost.

Figure 5-32 Software Reset Recovery

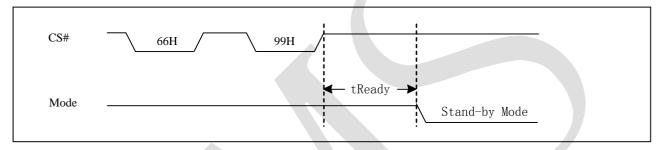
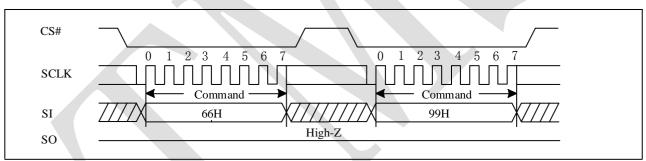


Figure 5-32a Reset Sequence



5.33. Read Unique ID (RUID)

The Read Unique ID command accesses a factory-set read-only 128bit number that is unique to each TH25Dxx device. The Unique ID can be used in conjunction with user software methods to help prevent copying or cloning of a system.

The Read Unique ID command sequence: CS# goes low \rightarrow sending Read Unique ID command \rightarrow Dummy Byte1 \rightarrow Dummy Byte2 \rightarrow Dummy Byte3 \rightarrow Dummy Byte4 \rightarrow 128bit Unique ID Out \rightarrow CS# goes high.

The command sequence is show below.

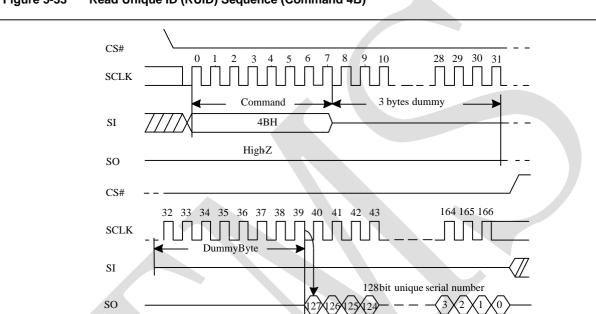


Figure 5-33 Read Unique ID (RUID) Sequence (Command 4B)

5.34. Read SFDP Mode (RDSFDP)

The Serial Flash Discoverable Parameter (SFDP) standard provides a consistent method of describing the functional and feature capabilities of serial flash devices in a standard set of internal parameter tables. These parameter tables can be interrogated by host system software to enable adjustments needed to accommodate divergent features from multiple vendors. The concept is similar to the one found in the Introduction of JEDEC Standard, JESD68 on CFI.

The sequence of issuing RDSFDP instruction is same as FAST_READ: CS# goes low \rightarrow send RDSFDP instruction (5Ah) \rightarrow send 3 address bytes on SI pin \rightarrow send 1 dummy byte on SI pin \rightarrow read SFDP code on SO \rightarrow to end RDSFDP operation can use CS# to high at any time during data out. The lower byte (A7~A0) of the address is the valid address which is corresponded to the Add in the Figure 5-34.

SFDP is a JEDEC Standard, JESD216B.

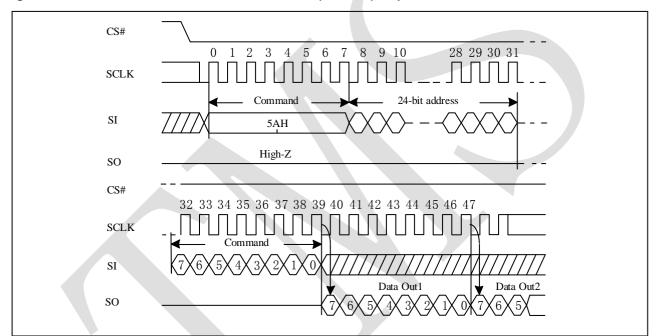


Figure 5-34 Read Serial Flash Discoverable Parameter (RDSFDP) Sequence

Figure 5-34a Serial Flash Discoverable Parameter (SFDP) Table

Table Signature and Parameter Identification Data Values

Description	Comment	Add(H)	DW Add	Data	Data
		(Byte)	(Bit)		
SFDP Signature	Fixed:50444653H	00H	07:00	53H	53H
		01H	15:08	46H	46H
		02H	23:16	44H	44H
		03H	31:24	50H	50H
SFDP Minor Revision Number	Start from 00H	04H	07:00	06H	06H
SFDP Major Revision Number	Start from 01H	05H	15:08	01H	01H
Number of Parameters Headers	Start from 00H	06H	23:16	01H	01H
Unused	Contains 0xFFH and can never be	07H	31:24	FFH	FFH
	changed				
ID number (JEDEC)	00H: It indicates a JEDEC specified	08H	07:00	00H	00H
	header				
Parameter Table Minor Revision	Start from 0x00H	09H	15:08	06H	<mark>06H</mark>
Number					
Parameter Table Major Revision	Start from 0x01H	0AH	23:16	01H	01H
Number					
Parameter Table Length	How many DWORDs in the	0BH	31:24	09H	09H
(in double word)	Parameter table				
Parameter Table Pointer (PTP)	First address of JEDEC Flash	0CH	07:00	30H	30H
	Parameter table	0DH	15:08	00H	00H
		0EH	23:16	00H	00H
Unused	Contains 0xFFH and can never be	0FH	31:24	FFH	FFH
	changed				
ID Number	It is indicates TMC	10H	07:00	EBH	EBH
(TMCDevice Manufacturer ID)	manufacturer ID				
Parameter Table Minor Revision	Start from 0x00H	11H	15:08	00H	00H
Number					
Parameter Table Major Revision	Start from 0x01H	12H	23:16	01H	01H
Number					
Parameter Table Length	How many DWORDs in the	13H	31:24	03H	03H
(in double word)	Parameter table				
Parameter Table Pointer (PTP)	First address of TMC Flash	14H	07:00	90H	90H
	Parameter table	15H	15:08	00H	00H
		16H	23:16	00H	00H
Unused	Contains 0xFFH and can never be	17H	31:24	FFH	FFH
	changed				



Table Parameter Table (0): JEDEC Flash Parameter Tables

Description	Comment	Add(H)	DW Add	Data	Data
		(Byte)	Bit		
Block/Sector Erase Size	00: Reserved; 01: 4KB erase; 10: Reserved;		01:00	01b	
BIOCK/Sector Erase Size	11: not support 4KB erase		01.00	010	
Write Granularity	0: 1Byte, 1: 64Byte or larger	-	02	1b	
Write Enable Instruction	0: Nonvolatile status bit				
Requested for Writing to Volatile	1: Volatile status bit		03	0b	
Status Registers	(BP status register bit)	30H			E5H
	0: Use 50H Opcode,	5011			LJII
	1: Use 06H Opcode,				
Write Enable Opcode Select for	Note: If target flash status register is		04	0b	
Writing to Volatile Status Registers	Nonvolatile, then bits3 and 4 must				
	be set to 00b.				
	Contains 111b and can never be	-			
Unused	changed		07:05	111b	
4KB Erase Opcode		31H	15:08	20Н	20H
(1-1- 2) Fast Read	0=Not support, 1=Support		16	1b	
Address Bytes Number used in	00: 3Byte only, 01: 3 or 4Byte,		10.15		
addressing flash array	10: 4Byte only, 11: Reserved		18:17	00Ь	
Double Transfer Rate (DTR)					
clocking	0=Not support, 1=Support	32H	19	0b	91H
(1-2- 2) FastRead	0=Not support, 1=Support		20	1b	
(1-4- 4) Fast Read	0=Not support, 1=Support		21	0b	
(1-1- 4) Fast Read	0=Not support, 1=Support		22	0b	
Unused			23	1b	
Unused		33H	31:24	FFH	FFH
Flash Memory Density		37H:34H	31:00	001FFF	FFH
(1-4- 4) Fast Read Number of Wait	0 0000b: Wait states (Dummy		04.00	000001	
states	Clocks) not support	2011	04:00	00000b	0.011
(1-4- 4) Fast Read Number of		38H			00H
Mode Bits	000b:Mode Bits not support		07:05	000b	
(1-4- 4) Fast Read Opcode		39H	15:08	FFH	FFH
(1-1- 4) Fast Read Number of Wait	0 0000b: Wait states (Dummy			000001	
states	Clocks) not support	2.17	20:16	00000b	0.011
(1-1- 4) Fast Read Number of		3AH			00H
Mode Bits	000b:Mode Bits not support		23:21	000b	
(1-1- 4) Fast Read Opcode		3BH	31:24	FFH	FFH



Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data
(1-1- 2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support		04:00	01000b	
(1-1-2) Fast Read Number of Mode Bits	000b: Mode Bits not support	3CH	07:05	000b	08H
(1-1- 2) Fast Read Opcode		3DH	15:08	3BH	3BH
(1-2- 2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	ЗЕН	20:16	00000b	80H
(1-2- 2) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	100b	
(1-2- 2) Fast Read Opcode		3FH	31:24	BBH	BBH
(2-2- 2) Fast Read	0=not support 1=support		00	0b	
Unused		40H	03:01	111b	EEH
(4-4- 4) Fast Read	0=not support 1=support	4011	04	Ob	EEH
Unused			07:05	111b	
Unused		43H:41H	31:08	0xFFH	0xFFH
Unused		45H:44H	15:00	0xFFH	0xFFH
(2-2- 2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	4611	20:16	00000Ь	0011
(2-2- 2) Fast Read Number of Mode Bits	000b: Mode Bits not support	46H	23:21	000b	00H
(2-2- 2) Fast Read Opcode		47H	31:24	FFH	FFH
Unused		49H:48H	15:00	0xFFH	0xFFH
(4-4- 4) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	4AH	20:16	00000b	00H
(4-4- 4) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	000b	0011
(4-4- 4) Fast Read Opcode		4BH	31:24	FFH	FFH
Sector Type 1 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	4CH	07:00	0CH	0CH
Sector Type 1 erase Opcode		4DH	15:08	20H	20H
Sector Type 2 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	4EH	23:16	0FH	0FH
Sector Type 2 erase Opcode		4FH	31:24	52H	52H
Sector Type 3 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	50H	07:00	10H	10H
Sector Type 3 erase Opcode		51H	15:08	D8H	D8H
Sector Type 4 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	52H	23:16	00H	00H
Sector Type 4 erase Opcode		53H	31:24	FFH	FFH



Table Parameter Table (1): TMC Flash Parameter Tables

Description	Comment	Add(H)	DW Add	Data	Data
Description	Comment	(Byte)	(Bit)	Data	Data
	2000H=2.000V				
Vcc Supply Maximum Voltage	2700H=2.700V	91H:90H	15:00	3600H	3600H
	3600H=3.600V				
	1650H=1.650V				
Vcc Supply Minimum Voltage	2250H=2.250V	93H:92H	31:16	1650H	1650H
	2350H=2.350V				
	2700H=2.700V				
HW Reset# pin	0=not support 1=support		00	Ob	
HW Hold# pin	0=not support 1=support		01	Ob	
Deep Power Down Mode	0=not support 1=support		02	1b	
SW Reset	0=not support 1=support		03	1b	
SW Reset Opcode	Should be issue Reset Enable(66H)	95H:94H	11:04	1001 1001b	799CH
S W Resei Opcode	before Reset cmd.	9511.9411	11.04	(99H)	755011
Program Suspend/Resume	0=not support 1=support		12	1b	
Erase Suspend/Resume	0=not support 1=support		13	1b	
Unused			14	1b	
Wrap Around Read mode	0=not support 1=support		15	0b	
Wrap - Around Read mode Opcode		96H	23:16	FFH	FFH
	08H:support 8B wraparound read				
Wrap - Around Read data length	16H:8B&16B	97H	31:24	00H	00H
wrap - Around Read data length	32H:8B&16B&32B	9/11	51.24	0011	0011
	64H:8B&16B&32B&64B				
Individualblock lock	0=not support 1=support		00	0b	
Individual block lock bit (Volatile/Nonvolatile)	0=Volatile 1=Nonvolatile		01	Ob	
Individual block lock Opcode			09:02	FFH	
Individual blocklock Volatile protect bit default protect status	0=protect 1=unprotect	9BH:98H	10	0b	CBFCH
Secured OTP	0=not support 1=support	_	11	1b	
Read Lock	0=not support 1=support	1	12	Ob	
Permanent Lock	0=not support 1=support	1	13	Ob	
Unused		1	15:14	11b	
Unused		1	31:16	FFFFH	FFFFH

6. Ordering Information

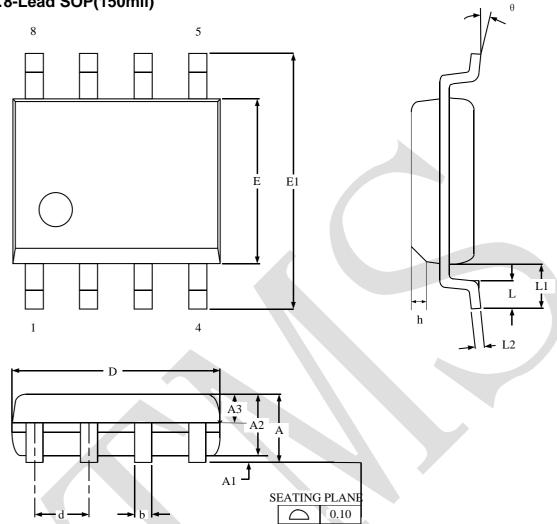
	<u>TH 25D - 20 U A - WFA I</u>
Compony Designator	
Company Designator TH=TsingHuaic	
in isinghuare	
Product serial	
25D=SPI NOR	
Memory density	
20=2Mbit 40=4Mbit	
80=8Mbit	
16=16Mbit	
10=10Mbit	
Operation voltage	
U=1.65 [°] 3.6V L=1.65 [°] 2.0V	
$H=2.3^{\circ}3.6V$	
Generation	
A=A version	
B=B version	
Ded and the	
Package type WFA=unsawn WAFER	
MSA=SOP8 150mil Tube	
MSB=SOP8 208mil Tube	
MSC=SOP8 150mil Reel	
MTA=TSSOP8 Reel UXA=USON8 3x2mm Reel	
UXB=USON8 1.5x1.5mm Reel	
UXC=USON8 3x2mm Ree1 Wide Epad	
WXA=WSON8 6x5mm Tray	
Device Grade	
$\frac{1}{1 = -40^{\circ}85C}$	
$V = 10^{\circ} 10^{\circ}$	

 $K = -40^{\sim} 105C$



7. Package Information

7.1.8-Lead SOP(150mil)



D '	
1)imc	neinne
	ensions

b

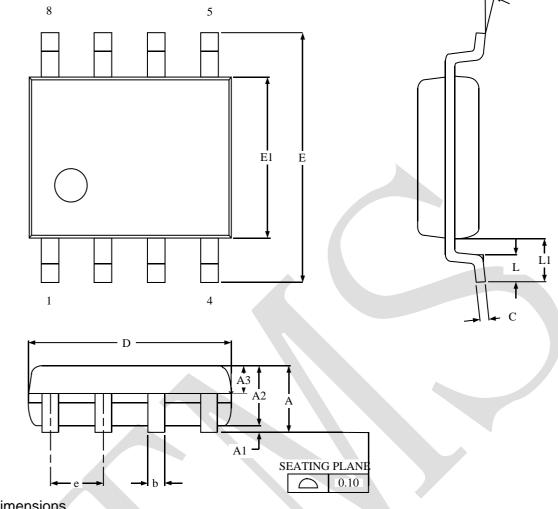
Symb	loc	А	A1	A2	A3	h	D	Е	E1	d	I	L1	L2	h	θ
Unit		~	AI	AZ	AJ	b	U	L		u	L	LI	LZ		0
	Min	1.35	0.10	1.25	0.5	0.38	4.80	3.80	5.80	1 27		0.20	0.25	0	
mm	Nom	1.55	0.15 1.40 0.6 - 4.90 3.90 5.90	1.27 BSC 0.60	1.04 REF	-	-	-							
	Max	1.75	0.25	1.65	0.7	0.51	5.00	4.00	6.20	200	0.80		0.24	0.50	8
	Min	0.53	0.004	0.050	0.020	0.015	0.189	0.150	0.228		0.018		0.008	0.010	0
Inch	Nom	0.61	0.006	0.055	0.024	-	0.193	0.154	0.236	0.050 BSC	0.024	0.041 REF	-	-	-
	Max	0.069	0.010	0.065	0.028	0.020	0.197	0.158	0.244		0.031		0.009	0.020	8

TITLE	DRAWING NO.	REV	REF
8-Lead SOP(150mil)		A	JEDEC MS-012



θ

7.2.8-Lead SOP(208mil)



D '	
I)IMA	nsions
	1310113

Symb	loc	A	A1	A2	A3	b	C	D	ш	E1		I	L1	θ
Unit		A	AT	AZ	AS	b	Ŭ		E	ΕI	е	L	LI	0
mm	Min		0.05	1.70	0.55	0.35	0.100	5.13	7.70	5.18		0.50	1.21	0
	Nom			1.80	0.60	0.43		5.23	7.90	5.28	1.27 BSC	0.65	1.31	-
	Max	2.15	0.25	1.90	0.65	0.50	0.250	5.33	8.10	5.38	200	0.85	1.41	8
	Min		0.002	0.067	0.022	0.014	0.004	0.202	0.303	0.204	0.050	0.020	0.048	0
Inch	Nom			0.071	0.024	0.017		0.206	0.311	0.208	0.050 BSC	0.026	0.052	-
	Max	0.085	0.010	0.075	0.026	0.020	0.010	0.210	0.319	0.212		0.033	0.056	8

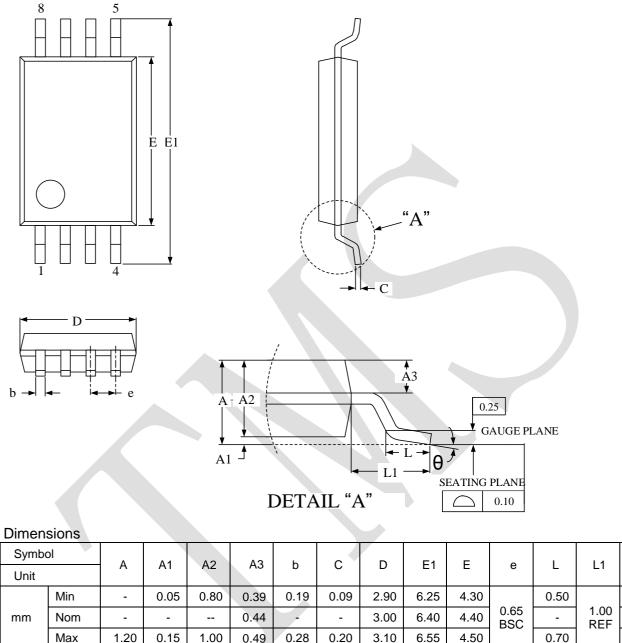
TITLE	DRAWING NO.	REV	REF
8-Lead SOP(208mil)		A	



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7.3.8-Lead TSSOP(173mil)

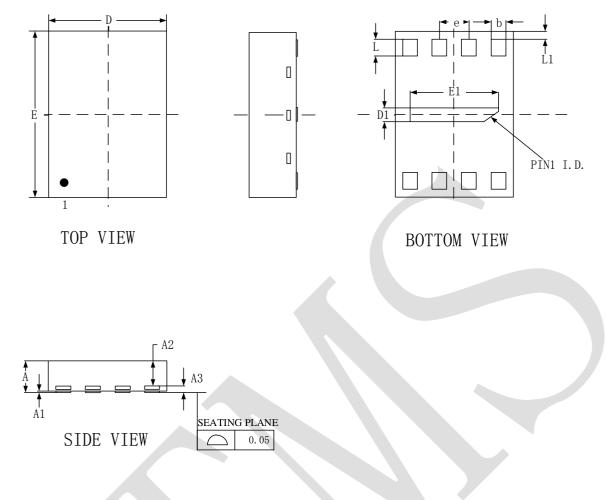


mm	Nom	-	-		0.44	-	-	3.00	6.40	4.40	BSC	-	REF	-	L
	Max	1.20	0.15	1.00	0.49	0.28	0.20	3.10	6.55	4.50	200	0.70		7	Ī
	Min	-	0.002	0.031	0.015	0.007	0.004	0.114	0.246	0.169		0.020	0.000	1	
Inch	Nom	-	-		0.017	-	-	0.118	0.252	0.173	0.026 BSC	-	0.039 REF	-	
	Max	0.047	0.006	0.039	0.019	0.012	0.008	0.122	0.258	0.177		0.028		7	

TITLE	DRAWING NO.	REV	REF
8-lead TSSOP		А	JEDEC MO-153



7.4.8-Land USON(3x2mm)



Dime	ensions												
Symbol				A2	A3	٢	L	Ľ	Е	E1			L1
Unit		A	A1	AZ	AS	D	b D D1			EI	е		LI
	Min	0.50	0.00	-	-	0.20	1.90	0.15	2.90	1.55		0.30	-
mm	Nom	0.55	0.02	0.40	0.15 REF	0.25	2.00	0.20	3.00	1.60	0.50 BSC	0.35	0.10 REF
	Max	0.60	0.05	-	-	0.30	2.10	0.25	3.10	1.65		0.40	-
	Min	0.020	0.00	-	-	0.008	0.075	0.006	0.114	0.061		0.012	-
Inch	Nom	0.021		0.012	0.006 REF	0.010	0.079	0.008	0.118	0.063	0.02 BSC	0.014	0.004 REF
	Max	0.024	0.002	-	-	0.012	0.083	0.010	0.122	0.065		0.016	-

TITLE	DRAWING NO.	REV	REF
DFN8L(0203X0.55-0.5)		A	JEDEC MO-252

7.5.8-Land WSON(6x5mm)

Max

0.032

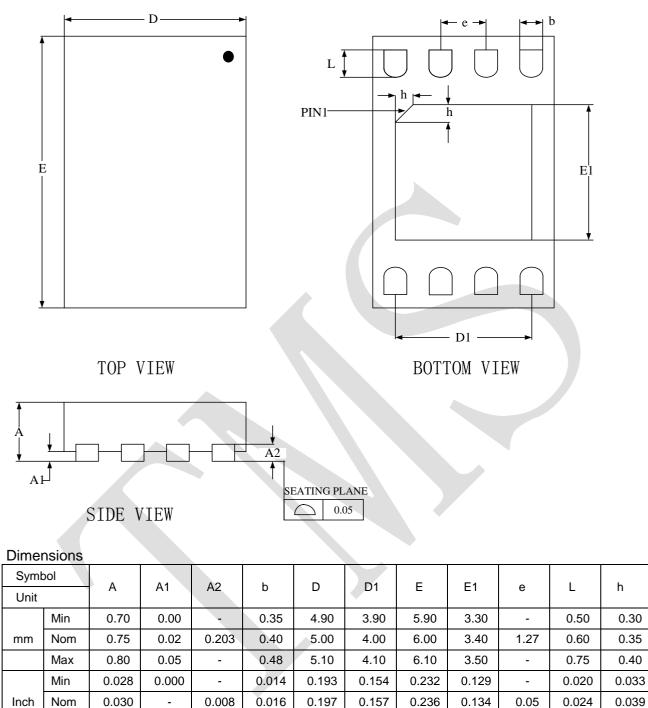
0.002

-

0.019

紫光青藤

IN



TITLE	DRAWING NO.	REV	REF
DFN8 (0506X0.75-1.27)		A	JEDEC MO-220

0.201

0.161

0.240

0.138

-

0.030

0.045

8. Revision History

Rev.	Date	Description	Author
V1.0	2019-7-26	Preliminary datasheet	Initial
V1.1	2020-5-18	 Update fSCLK frequency from 104MHz to 100MHz,for details 4.3AC Characteristics; Update fTSCLK frequency from 104MHz to 100MHz, for details 4.3AC Characteristics; 	wuxw
		3. Updata DC characteristics, for details 4.2DC Characteristics	
V1.2	2020-12-21	1. Update Hardware features	Xiechen
		2. Update Ordering Information	
V1.3	2021-06-10	1. Update tPRS/tERS timing	Wuxw